

# **Notice of References Cited**

Application/Control No.  
10/814,768

Applicant(s)/Patent Under  
Reexamination  
NAKAMURA ET AL.

Examiner  
Ronald D. Lafond

Art Unit  
1792

Page 1 of 1

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\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(e).)  
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